Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination CHUNG, SEUK Examiner Art Unit Phylesha L Dabney 2643 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	Α	US-6,611,605	08-2003	Kim, Jeong Uk	381/406
X	В	US-2003/0044031	03-2003	Son, Yeon Ho	381/182
X	С	US-6,487,300	11-2002	Lee et al.	381/396
X	D	US-6,466,682	10-2002	An, Sang Gil	381/413
X	Е	US-2002/0076068	06-2002	Chung, Seuk Hwan	381/150
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Τ					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.